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Mikhail Manokhin, Paul Chollet, Patricia Desgreys

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Flexible Analog-to-Feature converter for wireless smart healthcare sensors

Poster – Paper ID 9075







Mikhail Manokhin, Paul Chollet, Patricia Desgreys LTCI, Télécom Paris, Institut Polytechnique de Paris, France

Introduction

Conventional wireless sensor approach for event detection

- feature extraction and classification in the aggregator
- Nyquist rate sampling + wireless transmission of all samples
 - ⇒ energetically inefficient

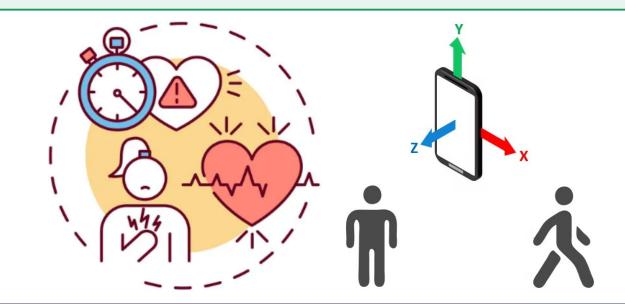
Analog-to-Feature (A2F) conversion

- extraction of only useful features from the analog signal
- features input data for ML algorithms for further classification
 - ⇒ facilitation of a low-power IoT deployment

Objective

Design of a generic, reconfigurable A2F converter for different low-frequency signals:

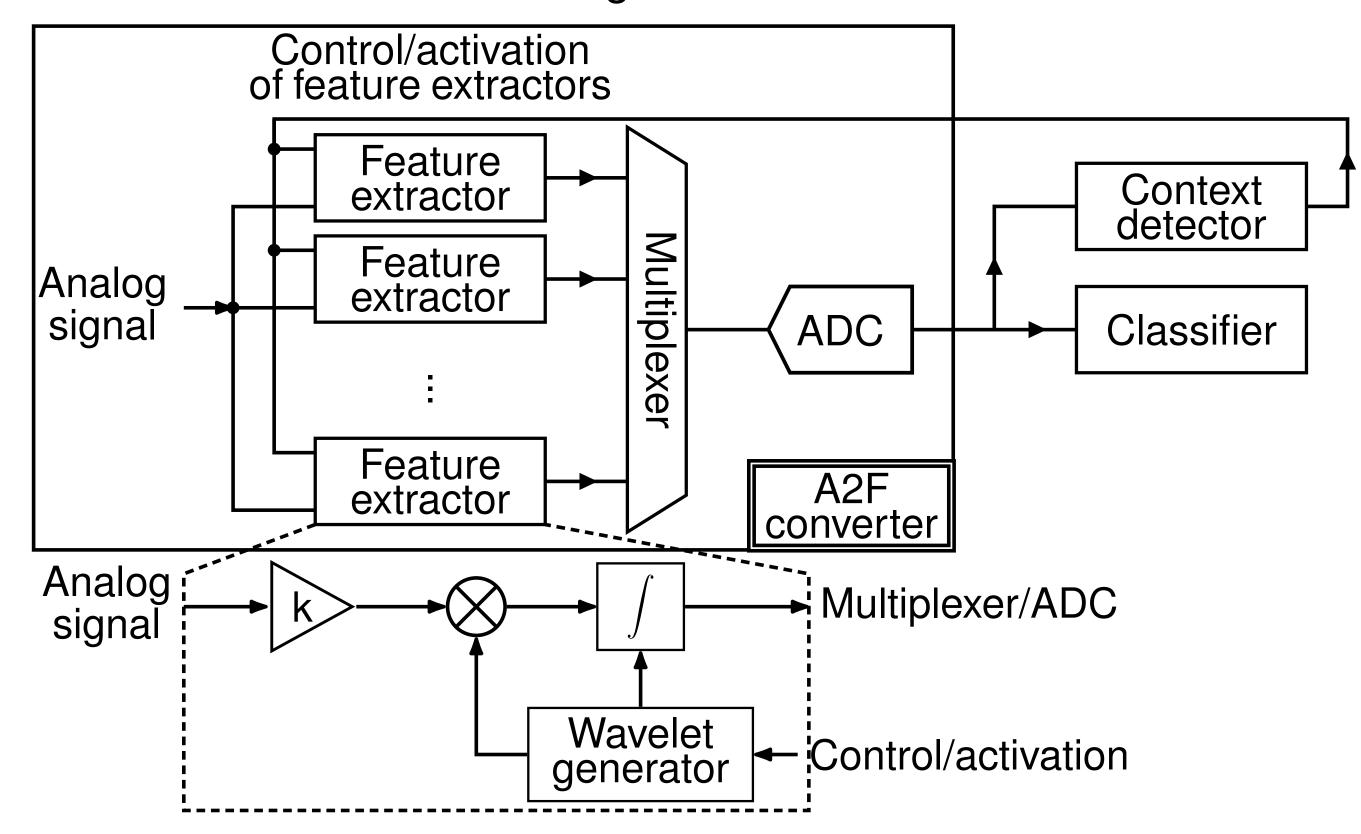
- arrhythmia detection in electrocardiogram (ECG) signals
- Human Activity Recognition (HAR) using inertial signals



Intelligent acquisition with A2F converter

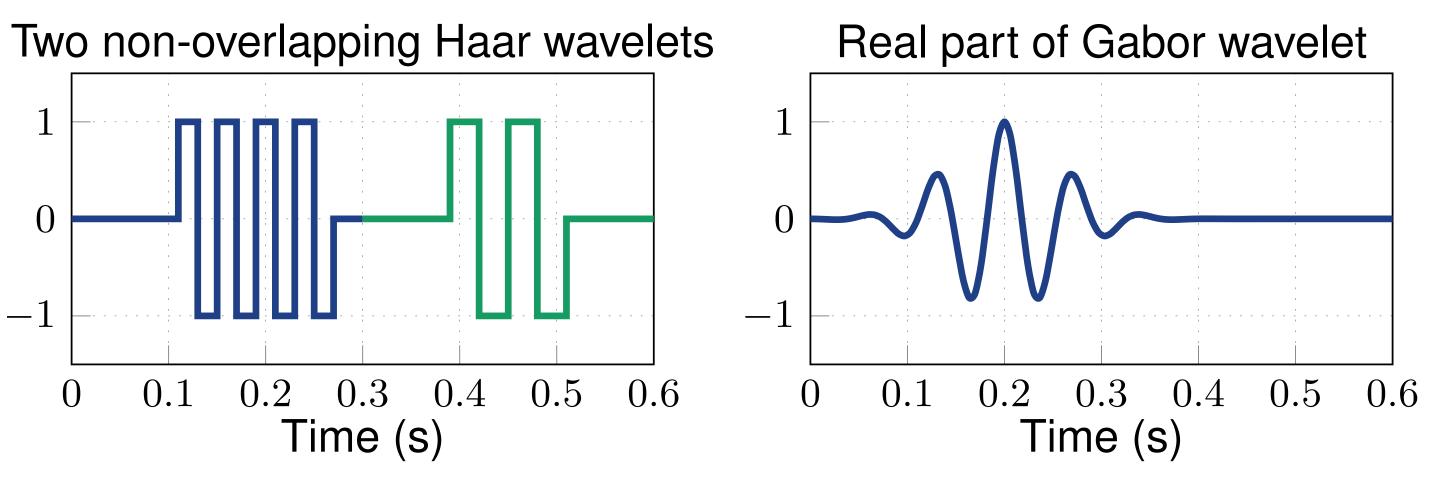
Proposed architecture

- NUWS-based feature extraction
- analog-to-digital conversion
- application-specific classification
- context detection for reconfiguration of extractors



Non-Uniform Wavelet Sampling (NUWS)

- mixing with tunable wavelets + integration in the analysis window
- obtains temporal and frequency information of input signal



large number of possible wavelets

despite reduced redundancy during the wavelet dictionaries' construction

Two-stage feature selection procedure

- Information Gain (IG)
 - independent ranking of available features
 - fast pre-selection of 100 best features without building a ML model
- Sequential Forward Search (SFS)
 - classifiers built with different subsets of features
- improved performance for a given type of classifier

Human activity recognition

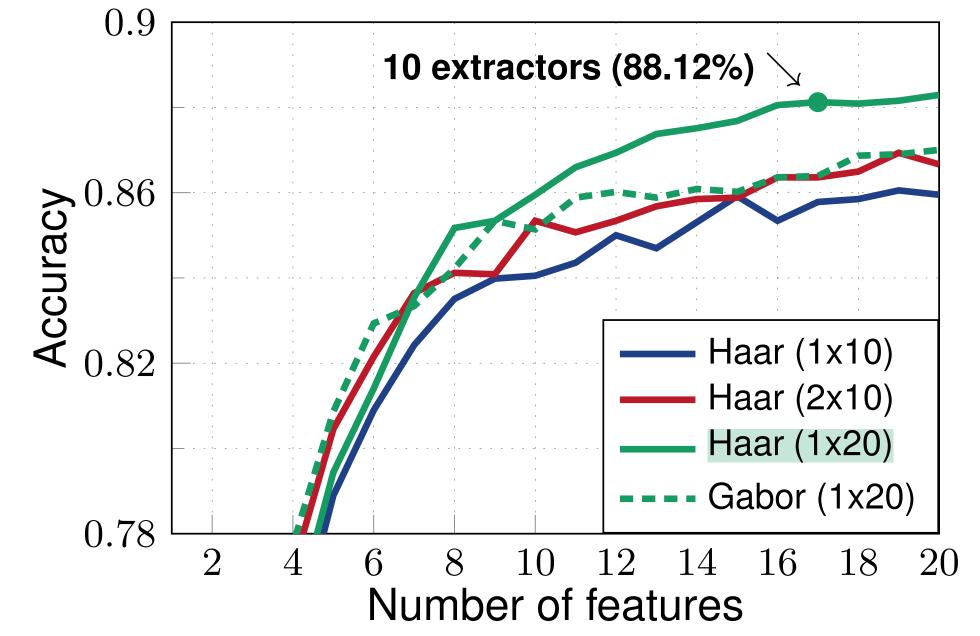
UCI-HAR dataset

- **signals**: 3-axial linear acceleration and angular velocity (50 Hz)
- 6 activities: walking, upstairs, downstairs, sitting, standing, laying
- training and test sets: 70/30% random partition
- analysis window: 128 samples of one annotated segment (2.56 s)

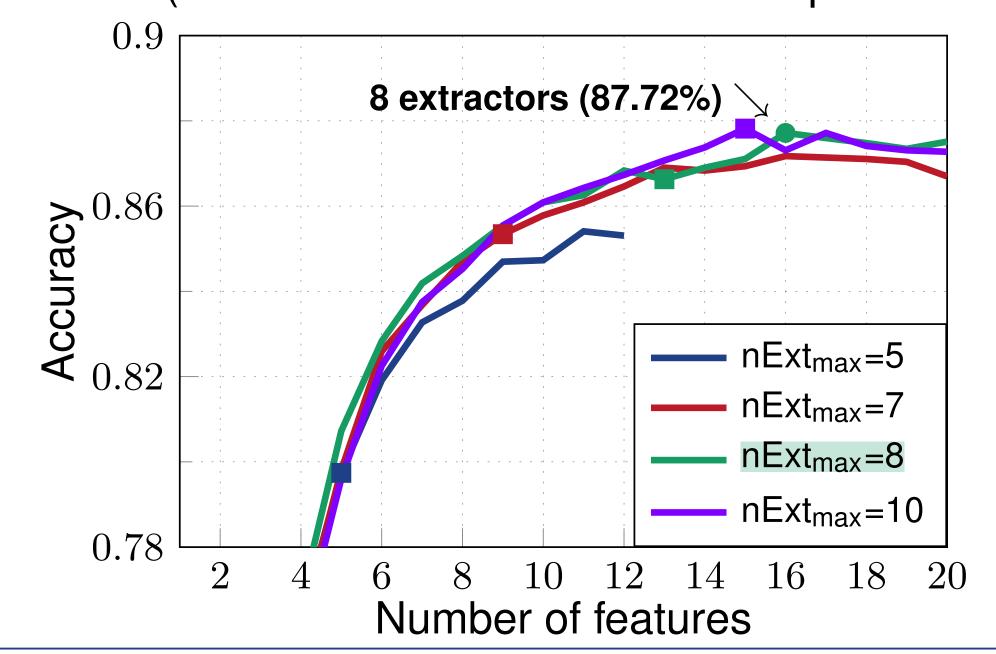
Simulation results

Multiclass classification

basic SFS (only maximizes the classification accuracy)



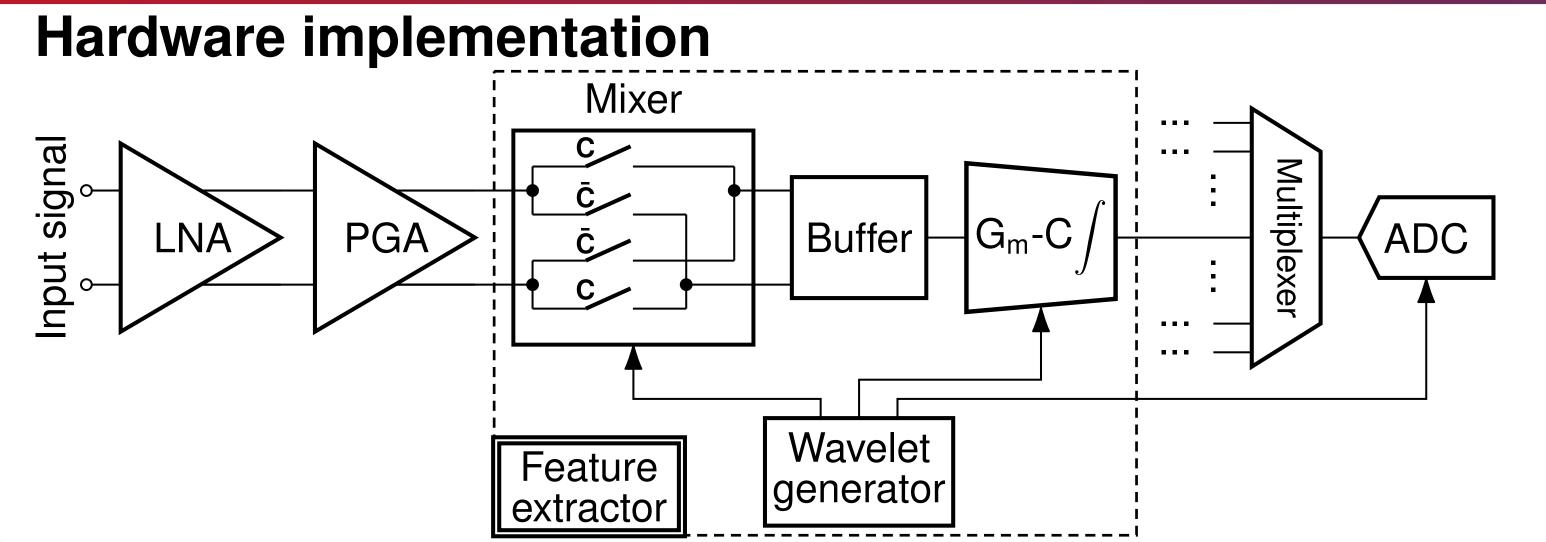
adapted SFS (limits the maximum number of parallel extractors)



Summary

Classification	Binary (one-vs-all)	Multiclass
N° of classifiers	6	1
N° of features	58 (total)	16
N° of extractors	min=1, max=8	8
Metric value	$MCC^*_{avg} = 0.860$	accuracy=0.877
Extracted features	NUWS with Haar wavelets	
Classifier model	Feedforward NN (1x20) trained during 1500 epochs	
*Matthews correlation coefficient		

Conclusion



Results summary

- proposal of a flexible A2F converter with NUWS-based feature extraction for event detection in wireless sensors
- simulation of HAR in addition to binary arrhythmia detection
- definition of hardware specifications for the physical implementation

Ongoing/upcoming work

- complete circuit design
- development of a modified optimized SFS algorithm power-aware feature selection based on the circuit simulations